

Search Notes**Application/Control No.**

10/822,772

Examiner

Jinhee J. Lee

**Applicant(s)/Patent under
Reexamination**

PARK ET AL.

Art Unit

2175

SEARCHED

Class	Subclass	Date	Examiner
715	719-726, 729, 730	6/22/2007	LEE
715	as above	4/27/2008	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	as above	6/22/2007	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search attached	6/22/2007	LEE
East search attached	4/27/2008	LEE